

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination VANDENTOP ET AL.	
		Examiner	Art Unit	Page 1 of 1
John B. Vigushin		2827		

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0065965 A1	05-2002	Sathe et al.	710/100
B	US-6,463,493 B1	10-2002	Hayes et al.	710/301
C	US-6,053,394	04-2000	Dockerty et al.	228/180.22
D	US-5,796,169	08-1998	Dockerty et al.	257/780
E	US-5,758,099	05-1998	Grieco et al.	710/301
F	US-5,490,040	02-1996	Gaudenzi et al.	361/773
G	US-5,475,261	12-1995	Tanizawa, Tetsu	257/693
H	US-5,309,324	05-1994	Herandez et al.	361/734
I	US-5,239,198	08-1993	Lin et al.	257/693
J	US-4,793,814	12-1988	Zifcak et al.	439/66
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.